# 13/D 3-31.03 Marish

TC-2800 MAIL ROOM

## N THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application Serial No	09/879,335
Filing Date	June 11, 2001 -
Inventor	Vishnu K. Agarwal, et al
Assignee	Micron Technology, Inc.
Group Art Unit	
Examiner	
Attorney's Docket No	Ml22-1568
Title: Capacitor Forming Methods with Barrie Inducing Material	er Layers to Threshold Voltage Shift

## PRELIMINARY AMENDMENT TO ACCOMPANY RCE FILING

To:

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Art Unit 2813

**Assistant Commissioner for Patents** 

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## **AMENDMENTS**

## In the Claims

Please add new claims 58-65 in accordance with 37 C.F.R. 1.121(c)(1)(i).

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- 58. The method of claim 1 wherein the barrier layer is formed on the insulation layer.
- 59. The method of claim 1 further comprising providing  $V_t$  shift inducing material over the insulation layer.
- 60. The method of claim 16 wherein the barrier layer is formed on the insulation layer.
- 61. The method of claim 22 wherein the barrier layer is formed on the substrate.